

**Notice of References Cited**

Application/Control No.

10/720,214

Applicant(s)/Patent Under  
Reexamination  
YEH ET AL.

Examiner

MATTHEW T. HENNING

Art Unit

2131

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,490,353 B1	12-2002	Tan, Daniel Tiong Hok	380/37
*	B	US-6,499,127 B1	12-2002	Kim et al.	714/739
*	C	US-5,442,342 A	08-1995	Kung, Kenneth C.	340/5.27
*	D	US-6,772,336 B1	08-2004	Dixon, Jr., Alfred R.	713/165
*	E	US-4,652,990	03-1987	Pailen et al.	705/56
*	F	US-6,636,970 B2	10-2003	Akiyama et al.	713/189
*	G	US-5,253,296 A	10-1993	Castleberry et al.	380/36
*	H	US-5,612,683 A	03-1997	Trempala et al.	340/5.23
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.